Notice of References Cited Application/Control No. 10/595,157 Examiner John L. Goff Applicant(s)/Patent Under Reexamination TAKENAKA ET AL. Page 1 of 1

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*	Α	US-4,081,600	03-1978	Kueneman et al.	174/251
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NON-PATENT DOCUMENTS

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	U	"Material Expansion Coefficients", pages 17-1 to 17-12, date 2002				
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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.